

Notice of References Cited

Application/Control No.	Applicant(s)/Pate	nt Under
10/091,502	Reexamination CHE ET AL.	. 2
Examiner	Art Unit	
Raymond Aleiandro	1745	Page 1 of 1

U.S. PATENT DOCUMENTS

	U.S. PATENT DOCUMENTS				
*	,	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A.	US-6,103,373	08-2000	Nishimura et al.	428/368
	В	US-6,399,251	06-2002	Honbo et al.	429/231.95
	С	US-6558846	05-2003	Tsushima et al	429/231.8
	D	US-		·	
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	j	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000-090972	03-2000	Japan	Kuruma et al	H01M 10/40
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	W	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.